

**Notice of References Cited**

Application/Control No.

09/760,950

Applicant(s)/Patent Under Reexam

Uriu et al.

Examiner

Tuyen T. Nguyen

Art Unit

2832

Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number		Date	Name	Classification <sup>2</sup>	
	Country	Code-Number-Kind Code	MM-YYYY <sup>1</sup>			
A		5,515,022	5/1996	Tashiro et al.	336	200
B						
C						
D						
E						
F						
G						
H						
I						
J						
K						
L						
M						

**FOREIGN PATENT DOCUMENTS**

	Document Number		Date	Country	Name	Classification <sup>2</sup>	
	Country	Code-Number-Kind Code	MM-YYYY <sup>1</sup>				
N		6-112047	4/1994	JP	Hirohashi	---	---
O							
P							
Q							
R							
S							
T							

**NON-PATENT DOCUMENTS**

Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages						
U						
V						
W						
X						

<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.